

Attorney's Docket No.: 07977-275001 / US4910

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IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

Applicant : Yoshiharu Hirakata et al. Art Unit : 2812
Serial No. : 09/854,120 Examiner : Ron Everett Pompey
Filed : May 10, 2001 Confirmation No.: 7408
Title : METHOD OF MANUFACTURING LIQUID CRYSTAL DISPLAY DEVICE

MAIL STOP AMENDMENT

Commissioner for Patents
P.O. Box 1450
Alexandria, VA 22313-1450

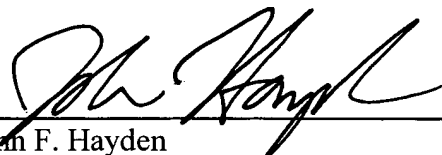
INFORMATION DISCLOSURE STATEMENT

Applicants would like to bring the Examiner's attention to the references listed on the attached form PTO-1449. It is respectfully requested each of the references listed on the attached form PTO-1449 be considered by the Examiner and that the document be initialed and returned to the undersigned.

This statement is being filed after a first Office action on the merits, but before receipt of a final Office action or a Notice of Allowance. A check for \$180 in payment of the late submission fee of C.F.R. § 1.17(p) is enclosed. Please apply any other charges or credits to Deposit Account No. 06-1050.

Respectfully submitted,

Date: March 16, 2005



John F. Hayden
Reg. No. 37,640

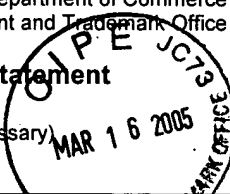
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Substitute Form PTO-1449 (Modified) Information Disclosure Statement by Applicant (Use several sheets if necessary) (37 CFR §1.98(b))	U.S. Department of Commerce Patent and Trademark Office 	Attorney's Docket No. 07977-275001	Application No. 09/854,120
		Applicant Yoshiharu Hirakata et al.	
		Filing Date May 10, 2001	Group Art Unit 2812

U.S. Patent Documents

Examiner Initial	Desig. ID	Document Number	Publication Date	Patentee	Class	Subclass	Filing Date If Appropriate
	AA	5,566,009	10-15-1996	Yamazaki et al.			05-23-1995
	AB	6,195,139	02-27-2001	Yamazaki et al.			07-02-1996
	AC	6,618,105	09-09-2003	Yamazaki et al.			02-13-2001
	AD						
	AE						
	AF						
	AG						
	AH						
	AI						
	AJ						
	AK						

Foreign Patent Documents or Published Foreign Patent Applications

Examiner Initial	Desig. ID	Document Number	Publication Date	Country or Patent Office	Class	Subclass	Translation	
							Yes	No
	AL							
	AM							
	AN							
	AO							
	AP							

Other Documents (include Author, Title, Date, and Place of Publication)

Examiner Initial	Desig. ID	Document
	AQ	
	AR	
	AS	
	AT	

Examiner Signature	Date Considered
EXAMINER: Initials citation considered. Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.	